

Search Notes**Application/Control No.**

10/788,836

Examiner

Jezia Riley

**Applicant(s)/Patent under
Reexamination**

LEE ET AL.

Art Unit

1637

SEARCHED

Class	Subclass	Date	Examiner
549	223		
435	6		
536	24.33 25.3		
536	26.6	9/3/2006	JR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
549	223		
435	6		
536	24.33 25.3		
536		6/26/2006	

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR